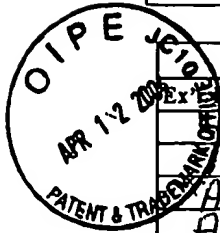


INFORMATION DISCLOSURE STATEMENT	Docket: P0419	Ser. No. 09/945,244
	Applicant: Sharma et al.	
	Filed: August 31, 2001	Group: 2621



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Ex'r Initial	Number	Date	Inventor	Class
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A-T	Dautzenberg, "Watermarking Images," Department of Microelectronics and Electrical Engineering, Trinity College Dublin, 47 pages, October 1994.
A-T	Hernandez et al., "Statistical Analysis of Watermarking Schemes for Copyright Protection of Images," Proceedings of the IEEE, vol. 87, No. 7, Jul. 1999.

Examiner Signature:

Abel Fazi Tabatabaei

Date Considered:

5/18/05

*Examiner: Initial if considered, whether or not in conformance with MPEP 609; draw line through cite if not in conformance and not considered. Include copy of this form with next communication to applicant.